


<b>Search Notes</b>  	<b>Application/Control No.</b>  10687715	<b>Applicant(s)/Patent Under Reexamination</b>  CHEN, MEI
	<b>Examiner</b>  Daley, Clifton G	<b>Art Unit</b>  2609

SEARCHED			
Class	Subclass	Date	Examiner
382	107	05/14/07	CGD
396	153	05/14/07	CGD
348	154, 155, 700	05/15/07	CGD

SEARCH NOTES		
Search Notes	Date	Examiner
Consulted Alexander Eisen (SPE); See EAST search	05/14/07	CGD
Consulted QEM/Chris Levin; Ref Doi	05/15/07	CGD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner